

# GSM6907Z

## 60V P-Channel MOSFETs

### Product Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

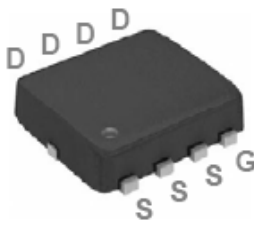
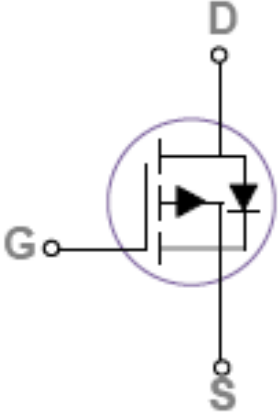
### Features

- -60V, -14A,  $R_{DS(ON)}=65m\Omega@V_{GS}=-10V$
- Fast switching
- Suit for -1.8V Gate Drive Applications
- Green Device Available
- Improved dv/dt capability

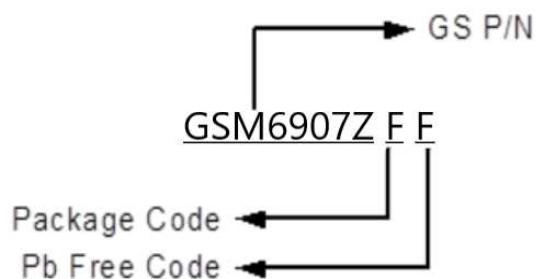
### Applications

- Motor Drive
- Power Tools
- LED Lighting

### Packages & Pin Assignments

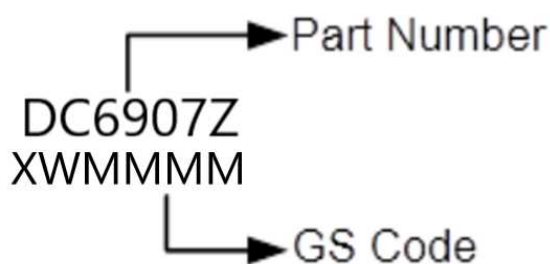
GSM6907ZFF (DFN3X3-8L)	
 <p>Top View</p>	
	
Pin	Description
1	Source
2	Source
3	Source
4	Gate
5	Drain
6	Drain
7	Drain
8	Drain

## Ordering Information



Part Number	Package	Quantity
GSM6907ZFF	DFN3X3-8L	5000pcs

## Marking Information



## Absolute Maximum Ratings

T<sub>C</sub>=25°C Unless otherwise noted

Symbol	Parameter	Typical	Unit
V <sub>DS</sub>	Drain-Source Voltage	-60	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Continuous Drain Current	T <sub>C</sub> =25°C	-14
		T <sub>C</sub> =100°C	-8.9
I <sub>DM</sub>	Pulsed Drain Current <sup>1</sup>	-56	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	31	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	-25	A
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> =25°C)	33.8	W
	Power Dissipation-Derate above 25°C	0.27	W/°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to +150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	°C
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	62	°C/W
R <sub>θJC</sub>	Thermal Resistance-Junction to Case	3.7	°C/W

## Electrical Characteristics

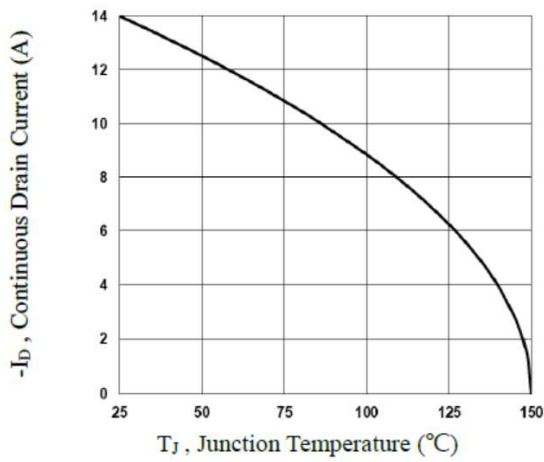
T<sub>J</sub>=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-60			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-1.2	-1.6	-2.2	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-60V, V <sub>GS</sub> =0V			-1	uA
		V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V T <sub>J</sub> =125°C			-10	
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current			-14	A
I <sub>SM</sub>	Pulsed Source Current				-28	A
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> = -10V, I <sub>D</sub> = -8A		54	65	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -6A		70	90	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-10V, I <sub>D</sub> =-3A		7		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V			-1	V
<b>Dynamic</b>						
Q <sub>g</sub>	Total Gate Charge <sup>3,4</sup>	V <sub>DS</sub> =-30V, V <sub>GS</sub> =-10V, I <sub>D</sub> =-3A		16.4	23	nC
Q <sub>gs</sub>	Gate-Source Charge <sup>3,4</sup>			2.8	4	
Q <sub>gd</sub>	Gate-Drain Charge <sup>3,4</sup>			3.6	6	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V, f=1MHz		870	1260	pF
C <sub>oss</sub>	Output Capacitance			70	100	
C <sub>rss</sub>	Reverse Transfer Capacitance			42	60	
t <sub>d(on)</sub>	Turn-On Time <sup>3,4</sup>	V <sub>DD</sub> =-30V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V, R <sub>G</sub> =6Ω		8.3	16	ns
t <sub>r</sub>				29.6	56	
t <sub>d(off)</sub>	Turn-Off Time <sup>3,4</sup>			51.7	98	
t <sub>f</sub>				15.6	30	
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz		16	32	Ω

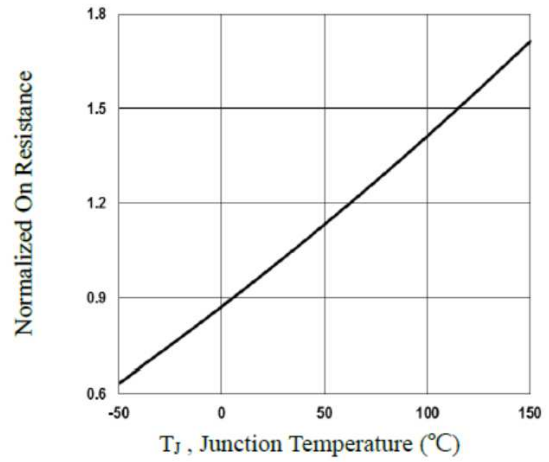
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V<sub>DD</sub>=-25V, V<sub>GS</sub>=-10V, L=0.1mH, I<sub>AS</sub>=-25A., R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C.
3. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
4. Essentially independent of operating temperature.

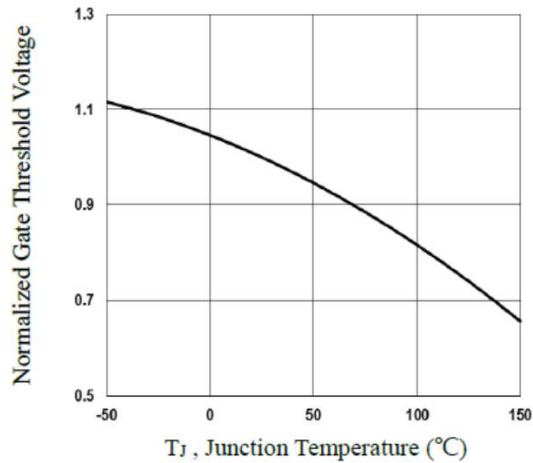
## Typical Performance Characteristics



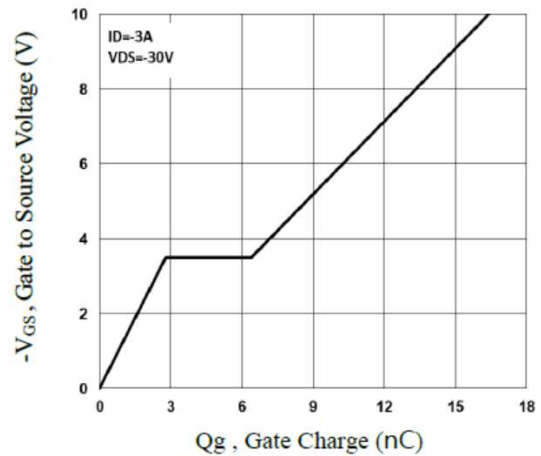
**Fig.1 Continuous Drain Current vs. T<sub>c</sub>**



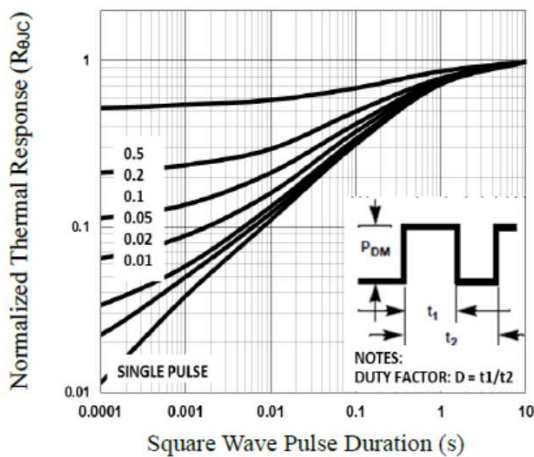
**Fig.2 Normalized R<sub>DS(on)</sub> vs. T<sub>J</sub>**



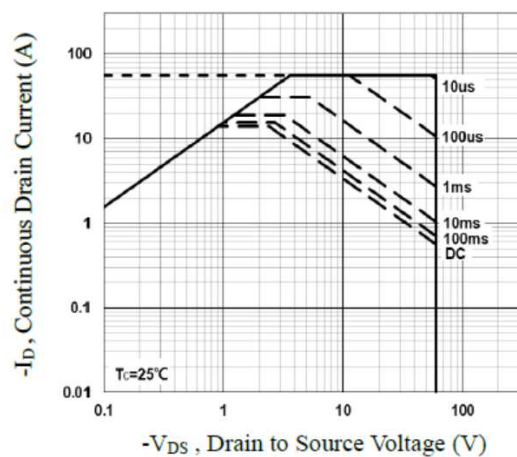
**Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>**



**Fig.4 Gate Charge Waveform**

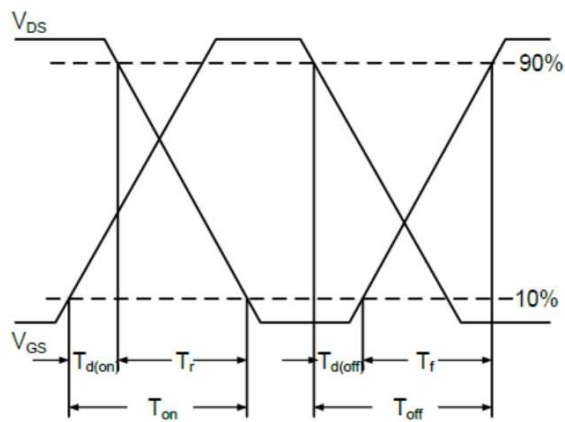


**Fig.5 Normalized Transient Impedance**

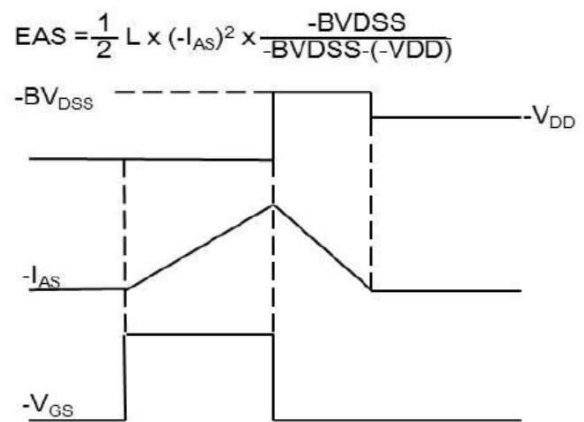


**Fig.6 Maximum Safe Operation Area**

## Typical Performance Characteristics (Continue)



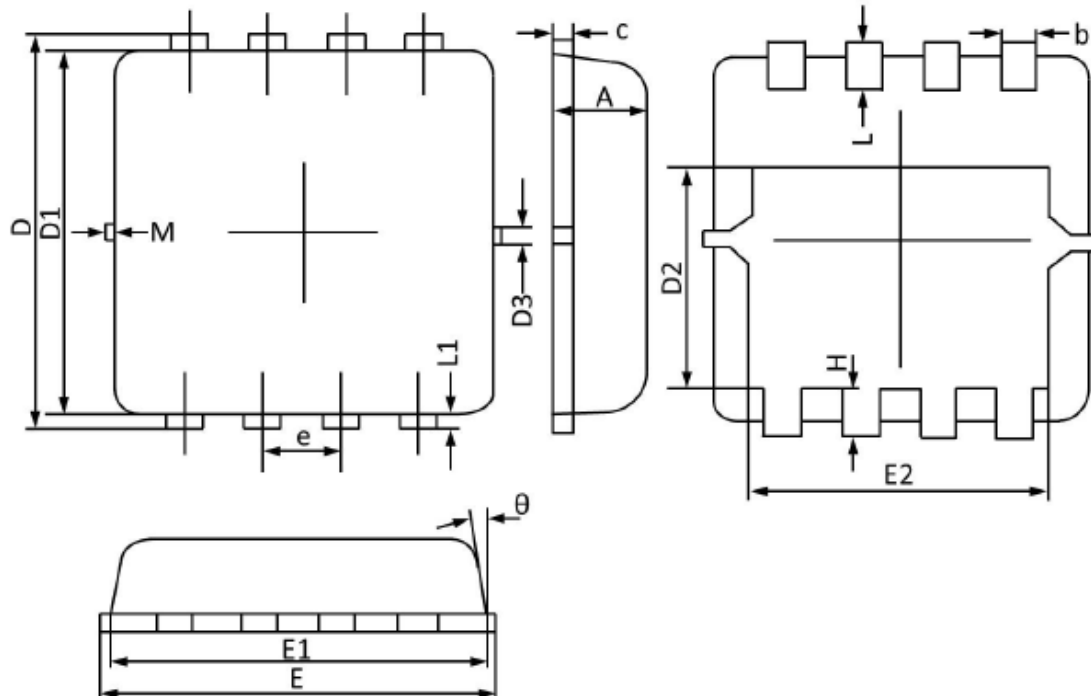
**Fig.7 Switching Time Waveform**



**Fig.8 EAS Waveform**

## Package Dimension

### DFN3X3-8L









Dimensions				
SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.013
c	0.100	0.250	0.004	0.009
D	3.250	3.450	0.128	0.135
D1	3.000	3.200	0.119	0.125
D2	1.780	1.980	0.070	0.077
D3	0.130 REF		0.005 REF	
E	3.200	3.400	0.126	0.133
E1	3.000	3.200	0.119	0.125
E2	2.390	2.590	0.094	0.102
e	0.650 BSC		0.026 BSC	
H	0.300	0.500	0.011	0.019
L	0.300	0.500	0.011	0.019
L1	0.130 REF		0.005 REF	
$\theta$	0°	12°	0°	12°
M	0.150 REF		0.006 REF	

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